

# Magnus Nord

## List of Publications by Year in descending order

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38  
papers

880  
citations

430874

18  
h-index

477307

29  
g-index

41  
all docs

41  
docs citations

41  
times ranked

1706  
citing authors

#	ARTICLE	IF	CITATIONS
1	Atomap: a new software tool for the automated analysis of atomic resolution images using two-dimensional Gaussian fitting. <i>Advanced Structural and Chemical Imaging</i> , 2017, 3, 9.	4.0	159
2	Electron Microscopy (Big and Small) Data Analysis With the Open Source Software Package HyperSpy. <i>Microscopy and Microanalysis</i> , 2017, 23, 214-215.	0.4	74
3	Silicon-core glass fibres as microwire radial-junction solar cells. <i>Scientific Reports</i> , 2014, 4, 6283.	3.3	52
4	Optimising multi-frame ADF-STEM for high-precision atomic-resolution strain mapping. <i>Ultramicroscopy</i> , 2017, 179, 57-62.	1.9	46
5	Characterisation of amorphous molybdenum silicide (MoSi) superconducting thin films and nanowires. <i>Superconductor Science and Technology</i> , 2017, 30, 084010.	3.5	45
6	The corrosion of Zr(Fe, Cr) <sub>2</sub> and Zr <sub>2</sub> Fe secondary phase particles in Zircaloy-4 under 350 Å°C pressurised water conditions. <i>Corrosion Science</i> , 2017, 128, 213-223.	6.6	44
7	Structural phases driven by oxygen vacancies at the La <sub>0.7</sub> Sr <sub>0.3</sub> MnO <sub>3</sub> /SrTiO <sub>3</sub> hetero-interface. <i>Applied Physics Letters</i> , 2015, 106, .	3.3	42
8	Fast Pixelated Detectors in Scanning Transmission Electron Microscopy. Part I: Data Acquisition, Live Processing, and Storage. <i>Microscopy and Microanalysis</i> , 2020, 26, 653-666.	0.4	39
9	Effect of Polar (111)-Oriented SrTiO <sub>3</sub> on Initial Perovskite Growth. <i>Crystal Growth and Design</i> , 2016, 16, 2357-2362.	3.0	32
10	Novel class of nanostructured metallic glass films with superior and tunable mechanical properties. <i>Acta Materialia</i> , 2021, 213, 116955.	7.9	32
11	Surface stability of epitaxial La <sub>0.7</sub> Sr <sub>0.3</sub> MnO <sub>3</sub> thin films on (111)-oriented SrTiO <sub>3</sub> . <i>Journal of Applied Physics</i> , 2013, 113, .	2.5	31
12	Strain Anisotropy and Magnetic Domains in Embedded Nanomagnets. <i>Small</i> , 2019, 15, e1904738.	10.0	30
13	Order and disorder in the magnetization of the chiral crystal $\text{CrNb}_3\text{S}_6$ . <i>Physical Review B</i> ,	3.2	27
14	Concurrent magnetic and structural reconstructions at the interface of (111)-oriented $\text{Li}_a\text{Mn}_r\text{S}_6$ .	3.2	26
15	LiberTEM: Software platform for scalable multidimensional data processing in transmission electron microscopy. <i>Journal of Open Source Software</i> , 2020, 5, 2006.	4.6	26
16	Fast Pixelated Detectors in Scanning Transmission Electron Microscopy. Part II: Post-Acquisition Data Processing, Visualization, and Structural Characterization. <i>Microscopy and Microanalysis</i> , 2020, 26, 944-963.	0.4	24
17	Electrochemical reduction of CO <sub>2</sub> to synthesis gas on CNT supported Cu <sub>x</sub> Zn <sub>1-x</sub> O catalysts. <i>Catalysis Today</i> , 2020, 357, 311-321.	4.4	22
18	Vanadium Substitution in $\text{Li}_2\text{MnSiO}_4/\text{C}$ as Positive Electrode for Li Ion Batteries. <i>Journal of Physical Chemistry C</i> , 2016, 120, 11359-11371.	3.1	20

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19	Assessing electron beam sensitivity for SrTiO <sub>3</sub> and La <sub>0.7</sub> Sr <sub>0.3</sub> MnO <sub>3</sub> using electron energy loss spectroscopy. Ultramicroscopy, 2016, 169, 98-106.	1.9	17
20	Quantitative strain analysis of InAs/GaAs quantum dot materials. Scientific Reports, 2017, 7, 45376.	3.3	17
21	Three-dimensional subnanoscale imaging of unit cell doubling due to octahedral tilting and cation modulation in strained perovskite thin films. Physical Review Materials, 2019, 3, .	2.4	12
22	Evaluation of different rectangular scan strategies for STEM imaging. Ultramicroscopy, 2020, 215, 113021.	1.9	10
23	In-plane structural order of domain engineered La <sub>0.7</sub> Sr <sub>0.3</sub> MnO <sub>3</sub> thin films. Philosophical Magazine, 2013, 93, 1549-1562.	1.6	9
24	Structural investigation of epitaxial LaFeO <sub>3</sub> thin films on (111) oriented SrTiO <sub>3</sub> by transmission electron microscopy. Journal of Physics: Conference Series, 2015, 644, 012002.	0.4	9
25	Liftout of High-Quality Thin Sections of a Perovskite Oxide Thin Film Using a Xenon Plasma Focused Ion Beam Microscope. Microscopy and Microanalysis, 2019, 25, 115-118.	0.4	8
26	Magnetic domain configuration of (111)-oriented LaFeO <sub>3</sub> epitaxial thin films. APL Materials, 2017, 5, .	5.1	7
27	Characterisation of a High-Power Impulse Magnetron Sputtered C/Mo/W wear resistant coating by transmission electron microscopy. Surface and Coatings Technology, 2019, 377, 124853.	4.8	4
28	Atomic resolution HOLZ-STEM imaging of atom position modulation in oxide heterostructures. Ultramicroscopy, 2021, 226, 113296.	1.9	4
29	Developing Rapid and Advanced Visualisation of Magnetic Structures Using 2-D Pixelated STEM Detectors. Microscopy and Microanalysis, 2016, 22, 530-531.	0.4	3
30	Strategy for reliable strain measurement in InAs/GaAs materials from high-resolution Z-contrast STEM images. Journal of Physics: Conference Series, 2017, 902, 012021.	0.4	2
31	Open Source Development Tools for Robust and Reproducible Electron Microscopy Data Analysis. Microscopy and Microanalysis, 2019, 25, 138-139.	0.4	2
32	Towards Mapping Perovskite Oxide 3-D Structure Using Two-Dimensional Pixelated STEM Detector. Microscopy and Microanalysis, 2016, 22, 476-477.	0.4	1
33	Atomap - Automated Analysis of Atomic Resolution STEM Images. Microscopy and Microanalysis, 2017, 23, 426-427.	0.4	1
34	Imaging Structure and Magnetisation in New Ways Using 4D STEM. Microscopy and Microanalysis, 2018, 24, 180-181.	0.4	1
35	Nanomagnets: Strain Anisotropy and Magnetic Domains in Embedded Nanomagnets (Small 52/2019). Small, 2019, 15, 1970287.	10.0	1
36	Materials Development Aided by Atomic-Resolution Electron Microscopy. Microscopy and Microanalysis, 2015, 21, 1515-1516.	0.4	0

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37	Methodology to Improve Strain Measurement in III-V Semiconductors Materials. <i>Microscopy and Microanalysis</i> , 2017, 23, 1416-1417.	0.4	0
38	Towards Reproducible and Transparent Science of (Big) Electron Microscopy Data Using Version Control. <i>Microscopy and Microanalysis</i> , 2019, 25, 232-233.	0.4	0